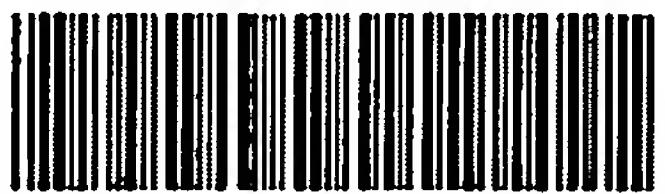


Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/604,419	SMITH ET AL.
Examiner	Art Unit
Duc M. Nguyen	2685

SEARCHED

Class	Subclass	Date	Examiner
455	423 424 425		
	67.11		
	115.1		
	115.3		
	115.4		
	226.1->		
	->226.4		
714	724 731		
	732 742		
	744 745		
341	126		
	131->155		
375	224->228		
370	241->252	10/26/A	JPV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Claim	search	10/26/2005	DN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)